

## THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of: Miwa KOZAWA et al.

Group Art Unit: 1752

Serial No.: 10/629,806

Examiner: Sin J. Lee

Filed: July 30, 2003

Confirmation Number: 9494

For:

RESIST PATTERN THICKENING MATERIAL, PROCESS FOR

FORMING RESIST PATTERN, AND PROCESS FOR MANUFACTURING SEMICONDUCTOR DEVICE

Attorney Docket Number: 030923

Customer Number:

38834

## AMENDMENT UNDER 37 CFR §1.111

Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450 September 29, 2005

Sir:

In response to the Office Action dated April 29, 2005, the response due date extended to September 29, 2005 by a 2-months Extension of Time, please amend the above-identified application as follows:

Amendments to the Claims begin on page 2 of this paper.

Remarks begin on page 9 of this paper.